

New Jersey Semi-Conductor Products, Inc.

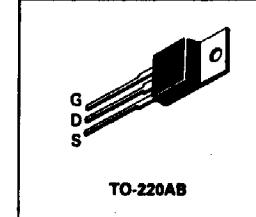
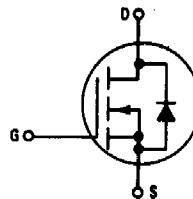
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Power Field Effect Transistor N-Channel Enhancement-Mode Silicon Gate

**BUZ71
BUZ71A**

TMOS POWER FETs
12 AMPERES
 $V_{DS(on)} = 0.10$ and
0.12 OHMS
50 VOLTS



MAXIMUM RATINGS

Rating	Symbol	BUZ71	BUZ71A	Unit
Drain-Source Voltage	V_{DSS}	50		Vdc
Drain-Gate Voltage ($R_{GS} = 20 \text{ k}\Omega$)	V_{DGR}	50		Vdc
Gate-Source Voltage	V_{GS}	± 20		Vdc
Drain Current — Continuous — Pulsed	I_D I_{DM}	12 48		Adc
Total Power Dissipation @ $T_C = 25^\circ\text{C}$ Derate above 25°C	P_D	40 0.32		Watts W/ $^\circ\text{C}$
Operating and Storage Temperature Range	T_J, T_{stg}	-55 to 150		°C

THERMAL CHARACTERISTICS

Thermal Resistance — Junction to Case — Junction to Ambient	R_{JC} R_{JA}	3.12 62.5	°C/W
Maximum Lead Temp. for Soldering Purposes, 1/8" from case for 5 seconds	T_L	275	°C

ELECTRICAL CHARACTERISTICS ($T_C = 25^\circ\text{C}$ unless otherwise noted)

Characteristic	Symbol	Min	Typ	Max	Unit
OFF CHARACTERISTICS					
Drain-Source Breakdown Voltage ($V_{GS} = 0, I_D = 1 \text{ mA}$)	$V_{(BR)DSS}$	50	—	—	Vdc
Zero Gate Voltage Drain Current ($V_{DS} = 50 \text{ Volts}, V_{GS} = 0$) ($V_{DS} = 50 \text{ Volts}, V_{GS} = 0, T_J = 125^\circ\text{C}$)	I_{DSS}	— —	— —	250 1000	μAdc
Gate-Body Leakage Current, Forward ($V_{GSF} = 20 \text{ Vdc}, V_{DS} = 0$)	I_{GSSF}	—	10	100	nAdc
Gate-Body leakage Current, Reverse ($V_{GSR} = 20 \text{ Vdc}, V_{DS} = 0$)	I_{GSSR}	—	10	100	nAdc

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Characteristic	Symbol	Min	Typ	Max	Unit
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ON CHARACTERISTICS*

Gate Threshold Voltage ($V_{DS} = V_{GS}$, $I_D = 10 \text{ mA}$)	$V_{GS(\text{th})}$	2.1	3.1	4	Vdc
Static Drain-Source On-Resistance ($V_{GS} = 10 \text{ Vdc}$, $I_D = 6 \text{ Adc}$)	$r_{DS(\text{on})}$	—	0.08 0.10	0.10 0.12	Ohm
Drain-Source On-Voltage ($V_{GS} = 10 \text{ V}$) ($I_D = 6 \text{ Adc}$) ($I_D = 6 \text{ Adc}$)	$V_{DS(\text{on})}$	— —	0.48 0.60	—	Vdc
Forward Transconductance ($V_{DS} = 25 \text{ V}$, $I_D = 6 \text{ A}$)	g_{FS}	3	5.5	—	mhos

DYNAMIC CHARACTERISTICS

Input Capacitance	$(V_{DS} = 25 \text{ V}, V_{GS} = 0,$ $f = 1 \text{ MHz})$	C_{iss}	—	—	650	μF
Output Capacitance		C_{oss}	—	—	450	
Reverse Transfer Capacitance		C_{rss}	—	—	280	
Total Gate Charge	$(V_{DS} = 40 \text{ V}, V_{GS} = 10 \text{ Vdc},$ $I_D = 12 \text{ A})$ See Figures 6 and 12	Q_g	—	14	—	nC

SWITCHING CHARACTERISTICS*

Turn-On Delay Time	$(V_{DD} = 30 \text{ V}, I_D = 3 \text{ A},$ $R_{gen} = 50 \text{ ohms})$ See Figures 11 and 12	$t_{d(on)}$	—	—	30	ns
Rise Time		t_r	—	—	85	
Turn-Off Delay Time		$t_{d(off)}$	—	—	90	
Fall Time		t_f	—	—	110	

SOURCE DRAIN DIODE CHARACTERISTICS*

Forward On-Voltage	$(I_S = 24 \text{ A},$ $V_{GS} = 0)$	V_{SD}	—	—	2.2	Vdc
Forward Turn-On Time		t_{on}	—	120	—	ns
Reverse Recovery Time		t_{rr}	—	110	—	ns

INTERNAL PACKAGE INDUCTANCE

Internal Drain Inductance (Measured from the contact screw on tab to center of die) (Measured from the drain lead 0.25" from package to center of die)	L_d	—	3.5	—	μH
Internal Source Inductance (Measured from the source lead 0.25" from package to source bond pad)	L_s	—	4.5	—	
			7.5	—	

*Pulse Test: Pulse Width < 300 μs , Duty Cycle < 2%.

